### Implementation of e-ID based on BDT in Athena EgammaRec

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## Motivation

- Lepton (e, μ, τ) Identification is crucial for new physics discoveries at the LHC, such as H→
  ZZ→4 leptons, H→WW→ 2 leptons + MET etc.
- ATLAS default electron-ID (IsEM) has relatively low efficiency (~67%), which has significant impact on ATLAS early discovery potential in H→WW, ZZ detection with electron final states.
- It is important and also feasible to improve e-ID efficiency and to reduce jet fake rate by making full use of available variables using BDT.

# **Electron ID Studies with BDT**

### Select electrons in two steps

- 1) Pre-selection: an EM cluster matching a track
- 2) Apply electron ID based on pre-selected samples with different e-ID algorithms (IsEM, Likelihood ratio, AdaBoost and **EBoost**).

### New BDT e-ID development at U. Michigan (Rel. v12)

H. Yang's talk at US-ATLAS Jamboree on Sept. 10, 2008
 <u>http://indico.cern.ch/conferenceDisplay.py?confld=38991</u>

#### New BDT e-ID (EBoost) based on Rel. v13

 H. Yang's talk at ATLAS performance and physics workshop at CERN on Oct. 2, 2008

http://indico.cern.ch/conferenceDisplay.py?confld=39296

### Implementation of EBoost in EgammaRec (Rel. v14)

### **Electrons**



Electron ID with BDT

### **Electron Pre-selection Efficiency**

The inefficiency mainly due to track matching



### Variables Used for BDT e-ID (EBoost)

#### The same variables for IsEM are used

egammaPID::ClusterHadronicLeakage

fraction of transverse energy in TileCal 1<sup>st</sup> sampling

egammaPID::ClusterMiddleSampling

Ratio of energies in 3\*7 & 7\*7 window Ratio of energies in 3\*3 & 7\*7 window Shower width in LAr 2<sup>nd</sup> sampling Energy in LAr 2<sup>nd</sup> sampling

egammaPID::ClusterFirstSampling

Fraction of energy deposited in 1<sup>st</sup> sampling Delta Emax2 in LAr 1<sup>st</sup> sampling Emax2-Emin in LAr 1<sup>st</sup> sampling Total shower width in LAr 1<sup>st</sup> sampling Shower width in LAr 1<sup>st</sup> sampling Fside in LAr 1<sup>st</sup> sampling • egammaPID::TrackHitsA0

B-layer hits, Pixel-layer hits, Precision hits Transverse impact parameter

• egammaPID::TrackTRT

Ratio of high threshold and all TRT hits

egammaPID::TrackMatchAndEoP

Delta eta between Track and egamma Delta phi between Track and egamma

- E/P egamma energy and Track momentum ratio
- Track Eta and EM Eta

• Electron isolation variables: Number of tracks ( $\Delta R=0.3$ ) Sum of track momentum ( $\Delta R=0.3$ ) Ratio of energy in  $\Delta R=0.2$ -0.45 and  $\Delta R=0.45$ 

# **BDT e-ID (EBoost) Training (v13)**

- BDT multivariate pattern recognition technique:
  [H. Yang et. al., NIM A555 (2005) 370-385]
- BDT e-ID training signal and backgrounds (jet faked e)
  - $W \rightarrow ev$  as electron signal (DS 5104, v13)
  - Di-jet samples (J0-J6), Pt=[8-1120] GeV (DS 5009-5015, v13)
- BDT e-ID training procedure
  - Event weight training based on background cross sections
    [H. Yang et. al., JINST 3 P04004 (2008)]
  - Apply additional cuts on the training samples to select hardly identified jet faked electron as background for BDT training to make the BDT training more effective.
  - Apply additional event weight to high  $P_T$  backgrounds to effective reduce the jet fake rate at high  $P_T$  region.

# Implementation of BDT Trees in EgammaRec Package and Test

- E-ID based on BDT has been implemented into egammaRec (04-02-98) package (private).
- We run through the whole reconstruction package based on v14.2.22 to test the BDT e-ID.



# E-ID Testing Samples (v13)

Wenu: DS5104 (Eff\_precuts = 89.1%)
 - 46554 electrons with Et>10 GeV, |η|<2.5</li>
 - 41457 electrons after pre-selection cuts

- JF17: DS5802 (Eff\_precuts = 7.7%)
  - 3893936 events, 14560093 jets
  - 1123231 jets after pre-selection

### Comparison of e-ID Algorithms (v13)



# E-ID Testing Samples (v14)

- Wenu: DS106020 (Eff\_precuts = 86.9%)
  - 173930 events, 173822 electrons
  - 130589 electrons with Et>10GeV,  $|\eta|$ <2.5
  - 113500 electrons with pre-selection cuts

- JF17: DS105802 (Eff\_precuts = 8%)
   475900 events, 1793636 jets
  - With pre-selection, 143167 jets

# E-ID Discriminators (v13 vs v14)



### Comparison of e-ID Algorithms (v14)



# Overall E-ID Efficiency and Jet Fake Rates (v13 vs. v14)

Test MC	Precuts	IsEM(tight)	LH>6.5	AdaBoost > 6	EBoost > 100
W→e <sub>V</sub> (v13)	89.1%	65.7%	78.5%	79.8%	84.3%
W→ev (v14)	86.9%	68.7%	70.9%	73.0%	80.0%
Eff. change	-2.2%	+3%	-7.6%	-6.8%	-4.3%
JF17 (v13)	7.7E-2	6.9E-4	3.7E-4	2.8E-4	1.9E-4
JF17 (v14)	8.0E-2	11E-4	<b>4.6E-4</b>	2.9E-4	1.9E-4
Relative change	+4%	+59%	+24%	+3.6%	0

## E-ID Efficiency vs Pt (v14)



# E-ID Efficiency vs $\eta$ (v14)



## Future Plan

- We have requested to add EBoost in ATLAS official egammaRec package and make EBoost discriminator variable available for physics analysis.
- We will provide EBoost trees to ATLAS egammaRec for each major software release
- Explore new variables and BDT training techniques to further improve the e-ID performance

### **Backup Slides**

### Jet Fake Rate (v14)



### List of Variables for BDT

- 1. Ratio of Et(∆R=0.2-0.45) / Et(∆R=0.2)
- 2. Number of tracks in  $\Delta R=0.3$  cone
- 3. Energy leakage to hadronic calorimeter
- 4. EM shower shape E237 / E277
- 5.  $\Delta\eta$  between inner track and EM cluster
- 6. Ratio of high threshold and all TRT hits
- 7. Number of pixel hits and SCT hits
- 8.  $\Delta \phi$  between track and EM cluster
- 9. Emax2 Emin in LAr 1<sup>st</sup> sampling
- 10. Number of B layer hits
- 11. Number of TRT hits
- 12. Emax2 in LAr 1<sup>st</sup> sampling
- 13. EoverP ratio of EM energy and track momentum
- 14. Number of pixel hits
- 15. Fraction of energy deposited in LAr 1<sup>st</sup> sampling
- 16. Et in LAr 2nd sampling
- 17.  $\eta$  of EM cluster
- 18. D0 transverse impact parameter
- 19. EM shower shape E233 / E277
- 20. Shower width in LAr 2<sup>nd</sup> sampling
- 21. Fracs1 ratio of (E7strips-E3strips)/E7strips in LAr 1st sampling
- 22. Sum of track Pt in DR=0.3 cone
- 23. Total shower width in LAr 1st sampling
- 24. Shower width in LAr 1st sampling

**EM Shower shape** distributions of discriminating Variables (signal vs. background)



0.8

 $E_{237}/E_{277}$ 

0.9



 $1'_{2}$ 

1.1

### **ECal and Inner Track Match**



0

0.5

0.025 0.05 0.075 0.1

Ó

 $\Delta\eta_{e\text{-trk}}$ 

0

-0.1 -0.075 -0.05 -0.025

3.5

3

2.5

1.5

E/P

### **Electron Isolation Variables**



### Example: H→ WW →IvIv Studies [H. Yang et.al., ATL-COM-PHYS-2008-023]

- At least one lepton pair (ee,  $\mu\mu$ ,  $e\mu$ ) with P<sub>T</sub> > 10 GeV,  $|\eta|$ <2.5
- Missing  $E_T > 20 \text{ GeV}$ , max( $P_T(I), P_T(I)$ ) > 25 GeV
- $|M_{ee} M_z| > 10$  GeV,  $|M_{\mu\mu} M_z| > 15$  GeV to suppress background from Z  $\rightarrow$  ee,  $\mu\mu$

Higgs Mass (GeV)	Eff(evev)	Eff( $\mu \nu \mu \nu$ )	$Eff(ev\mu v)$
140	26.3%	49.9%	34.2%
150	28.5%	51.1%	37.0%
160	29.9%	53.3%	39.9%
165	30.5%	54.1%	40.8%
170	30.5%	52.7%	42.2%
180	29.3%	50.1%	43.2%

Used ATLAS electron ID: IsEM & 0x7FF == 0

### Comparison of e-ID Algorithms (v14)



### Signal Pre-selection: MC electrons

- MC True electron from W  $\rightarrow$  ev by requiring -  $|\eta_e| < 2.5$  and  $E_T^{true} > 10$  GeV (N<sub>e</sub>)
- Match MC e/ $\gamma$  to EM cluster:

-  $\Delta R$ <0.2 and 0.5 < E<sub>T</sub><sup>rec</sup> / E<sub>T</sub><sup>true</sup>< 1.5 (N<sub>EM</sub>)

• Match EM cluster with an inner track:

 $-eg_trkmatchnt > -1$  (N<sub>EM/track</sub>)

• Pre-selection Efficiency =  $N_{EM/Track} / N_{e}$ 

### **Pre-selection of Jet Faked Electrons**

• Count number of jets with

-  $|\eta_{jet}|$  < 2.5,  $E_T^{jet}$  >10 GeV (N<sub>jet</sub>)

- Loop over all EM clusters; each cluster matches with a jet
   - E<sub>T</sub><sup>EM</sup> > 10 GeV (N<sub>EM</sub>)
- Match EM cluster with an inner track:

 $-eg_trkmatchnt > -1$  (N<sub>EM/track</sub>)

Pre-selection Acceptance = N<sub>EM/Track</sub> / N<sub>jet</sub>

## Comparisons of v13 and v14



## Comparisons of v13 and v14



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